

Search Notes**Application/Control No.**

10/561,957

Applicant(s)/Patent under Reexamination

NISHIZAWA, TSUYOSHI

Examiner

SEYED M. MALEKZADEH

Art Unit

1791

SEARCHED

Class	Subclass	Date	Examiner
438	456	3/28/2007	SMM
438	149	3/28/2007	SMM
438	156	3/29/2007	SMM
257	758	3/29/2007	SMM
117	84	9/21/2007	SMM
117	88,89	2/7/2008	SMM
117	90,94	2/7/2008	SMM
117	97,98	2/7/2008	SMM
117	105, 106	2/7/2008	SMM
117	107	2/7/2008	SMM

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
117	88-89,90	2/8/2008	SMM
117	94,97-98	2/8/2008	SMM
117	105-107	2/8/2008	SMM
PGPub text search (see search printout)		2/8/2008	SMM

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Use Palm Intranet to search inventor's name	3/28/2007	SMM
Use text search through EAST to find patents related to the application Examiner used key words such as "silicon wafer"	3/28/2007	SMM
Updated previous search	3/28/2007	SMM
Updated previous search	2/7/2008	SMM